



INFORMATION DISCLOSURE
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APPLICANT
Naoto HIROSAKI et al.

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GROUP
2879

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	2005-8793	1/13/2005	Japan				
	2005-8794	1/13/2005	Japan				
	2003-336059	11/28/2003	Japan				
	2004-277663	10/7/2004	Japan				
	2004-67837	3/4/2004	Japan				
	EP 1264 873 A2	12/11/2002	Europe				
	EP 1 278 250 A2	1/22/2003	Europe				
	DE 101 33 352 A1	2/6/2003	Germany				
	EP 1 296 383 A2	3/26/2003	Europe				
	DE 101 46 719 A1	4/17/2003	Germany				
	EP 1 296 376 A2	3/26/2003	Europe				
	DE 101 47 040 A1	4/24/2003	Germany				
	WO 2005/103198	11/3/05	Japan				
	2002-322474	11/8/02	Japan w/ English abstract				
	2003-277746	10/2/03	Japan w/ English abstract				
	2004-010786	1/15/04	Japan w/ English abstract				
	2004-182780	7/2/04	Japan w/ English abstract				
	2004-182781	7/2/04	Japan w/ English abstract				
	2004-189996	7/8/04	Japan w/ English abstract				
	2006-028295	02/02/06	JAPAN (English abstract)				
	2006-063286	03/09/06	JAPAN (English abstract)				
	2006-070109	03/16/06	JAPAN (English abstract)				

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Zhen-Kun HUANG, et al., "Phase relations of the Si ₃ N ₄ -AlN-CaO system", JOURNAL OF ALLOYS AND COMPOUNDS, 1985, page 255-259
H.A. Hoeppel, et al. "Luminescence in Eu ²⁺ -doped Ba ₂ Si ₅ N ₈ : fluorescence, thermoluminescence, and upconversion", Journal of Physics and Chemistry of Solids 61; 2000; pp. 2001-2008
J.W.H. van Krevel "On new rare-earth doped M-Si-Al-O-N materials"; TU Eindhoven; 2000; pp. 1-173

EXAMINER	DATE CONSIDERED

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